Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10575425	PROUET ET AL.
Examiner	Art Unit
JOHN W POOS	2816

SEARCHED				
Class	Subclass	Date	Examiner	
327	103	11/29/2007	JP	
323	315	12/3/2007	JP	
323	312	4/30/2009	JP	

SEARCH NOTES				
Search Notes	Date	Examiner		
terms used to constrain subclasses above: chip, different sized transistors, transconductance, differential input voltage	11/29/2007	JP		
Inventor search in EAST and eDAN	12/3/2007	JP		
Update Search see attached Search History	4/25/2008	JP		
Update Search: see attached EAST search history	10/10/2008	JP		
Update search see attached EAST search history	4/30/2009	JP		
backward and forward citation search on all pertinent references	4/30/2009	JP		
IDS search for IDS filed 8/3/2009	9/1/2009	JP		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	see attached EAST history	9/1/2009	JP

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